Notice of References Cited Application/Control No. 10/541,525 Examiner Andrew C. Lee Applicant(s)/Patent Under Reexamination KUMAZAWA ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,751,955	05-1998	Sonnier et al.	714/12
*	В	US-5,778,187	07-1998	Monteiro et al.	709/231
*	С	US-2005/0157741	07-2005	Wu et al.	370/432
*	D	US-5,457,683	10-1995	Robins, Nicholas	370/258
*	Е	US-6,148,411	11-2000	Ichinohe et al.	714/4
*	F	US-5,473,599	12-1995	Li et al.	370/219
*	G	US-2002/0184387	12-2002	Yamaya et al.	709/238
*	Н	US-7,099,326	08-2006	Flinck et al.	370/392
*	I	US-6,192,029	02-2001	Averbuch et al.	370/229
*	J	US-6,826,154	11-2004	Subbiah et al.	370/236
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	>					
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	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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